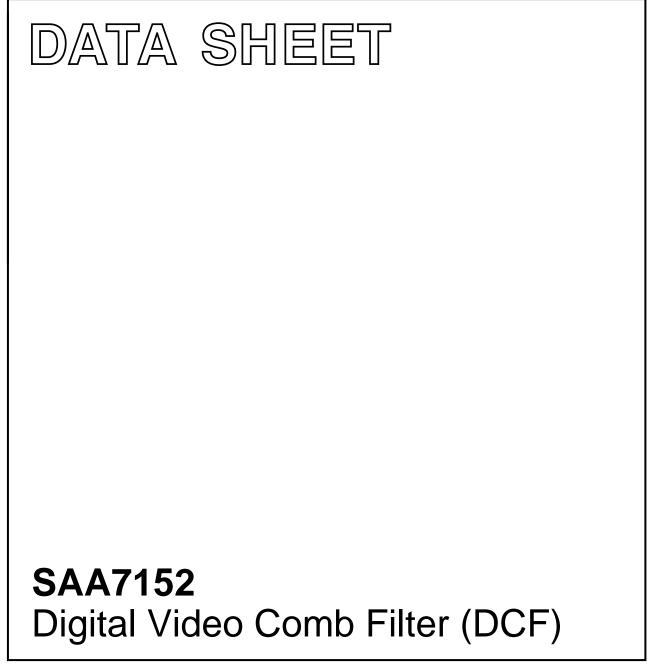
INTEGRATED CIRCUITS



Product specification File under Integrated Circuits, IC02 August 1996



HILIPS

## SAA7152



#### FEATURES

- Comb filter circuit for luminance and chrominance separation
- · Applicable for standards
  - PAL B/G, M and N
  - PAL 4.43 (525 lines, 60 Hz)
  - NTSC M and N
  - NTSC 4.43 (50 and 60 Hz)
- Luminance and chrominance bypasses with short delay in case of no filtering
- Line-locked system clock; CCIR-compatible
- I<sup>2</sup>C-bus controlled

#### **GENERAL DESCRIPTION**

The CMOS digital comb filter circuit is located between video analog-to-digital converters and the video multistandard decoder SAA7151B (not applicable for SAA7191B). The two-dimensional filtering is only appropriate for standard signals from a source with constant phase relationship between subcarrier signal and horizontal frequency. The comb-filter has to be switched off for VTR-signals and for separate VBS and C signals. In VCR and S-Video operation the luminance low-pass and the chrominance bandpass parts can still be used for noise reduction purposes. The processing delay is:

 $21 \times \text{LL27}$  clocks in active mode, or

 $3 \times$  LL27 in short delay bypass mode (BYPS = 1)

#### QUICK REFERENCE DATA

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
V <sub>DD</sub>	supply voltage (pins 11, 34, 44)	4.5	5.0	5.5	V
I <sub>P</sub>	total supply current	_	85	180	mA
Vi	input levels	TTL-compatible			
Vo	output levels	TTL-compatible			
LL27	typical system clock frequency	_	27	-	MHz
T <sub>amb</sub>	operating ambient temperature range	0	-	70	°C

#### **ORDERING INFORMATION**

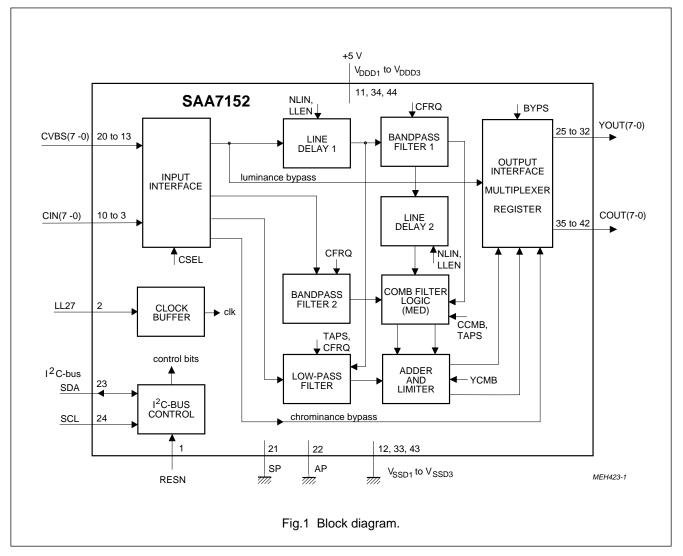
EXTENDED	PACKAGE						
TYPE NUMBER	PINS	PIN POSITION	MATERIAL	CODE			
SAA7152	44	PLCC	plastic	SOT187 <sup>(1)</sup>			

#### Note

1. SOT187-2; 1997 January 06.

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#### **BLOCK DIAGRAM**



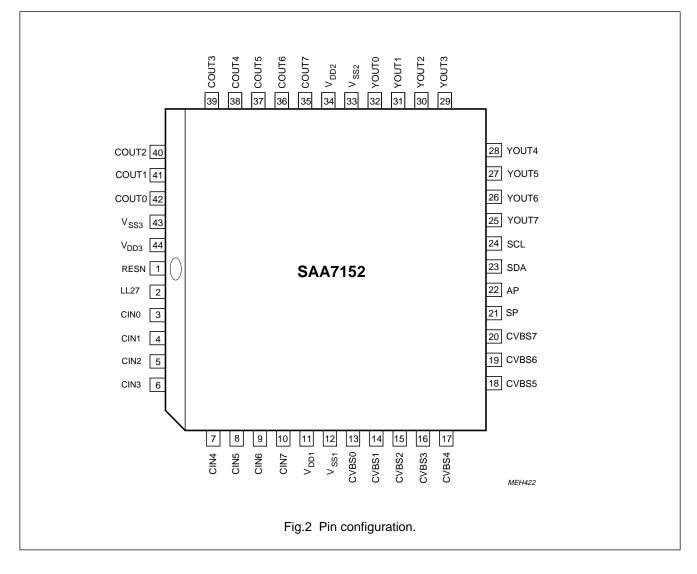
## SAA7152

#### PINNING

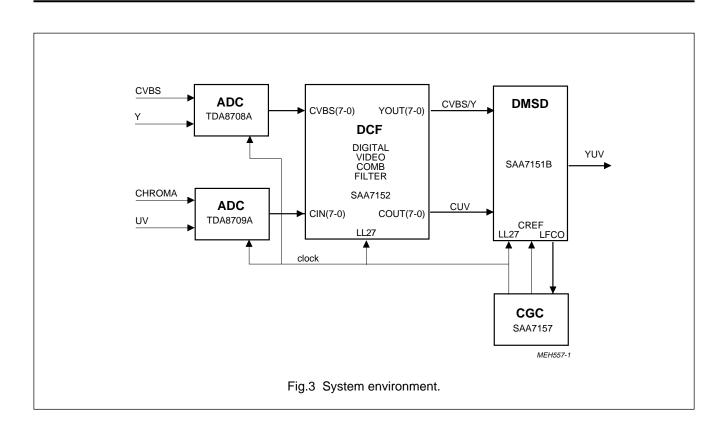
SYMBOL	PIN	DESCRIPTION	
RESN	1	reset input; active low	
LL27	2	line-locked system clock input (27 MHz)	
CIN0	3		
CIN1	4		
CIN2	5		
CIN3	6		
CIN4	7	— chrominance input data bits CIN0 to CIN7	
CIN5	8		
CIN6	9		
CIN7	10		
V <sub>DD1</sub>	11	+5 V supply input	
V <sub>SS1</sub>	12	ground 1 (0 V)	
CVBS0	13		
CVBS1	14		
CVBS2	15		
CVBS3	16		
CVBS4	17	CVBS input data bits 0 to 7	
CVBS5	18		
CVBS6	19		
CVBS7	20		
SP	21	connected to ground (shift pin for testing)	
AP	22	connected to ground (action pin for testing)	
SDA	23	I <sup>2</sup> C-bus data line	
SCL	24	I <sup>2</sup> C-bus clock line	
YOUT7	25		
YOUT6	26		
YOUT5	27		
YOUT4	28	luminanaa (V) autaut data hita 7 ta 0	
YOUT3	29	Iuminance (Y) output data bits 7 to 0	
YOUT2	30		
YOUT1	31		
YOUT0	32		
V <sub>SS2</sub>	33	ground 2 (0 V)	
V <sub>DD2</sub>	34	+5 V supply input 2	

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SYMBOL	PIN	DESCRIPTION
COUT7	35	
COUT6	36	
COUT5	37	
COUT4	38	
COUT3	39	— chrominance (C) output data bits 7 to 0
COUT2	40	
COUT1	41	
COUT0	42	
V <sub>SS3</sub>	43	ground 3 (0 V)
V <sub>DD3</sub>	44	+5 V supply input 3



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### SAA7152

#### I<sup>2</sup>C-BUS FORMAT

	S	SLAVE	ADDRESS	Α	SUBADDRESS	Α	DATA0	Α	DATAn	Α	Р
S			=	start o	start condition						
SLAVE ADDRESS = 1011 0010 (B2 h)											
А			=	acknowledge, generated by the slave							
SUBA	DDR	ESS <sup>(1)</sup>	=	subaddress byte (Table 1)							
DATA			=	data byte (Table 1)							
Р			=	stop o	condition						
Х			=	read/write control bit							
				X = 0	order to write (the	circui	t is slave re	eceiver)			
				X = 1	order to read (the	circuit	is slave tra	ansmitter)			

#### Note

1. If more than 1 byte DATA are transmitted, then auto-increment of the subaddress is performed.

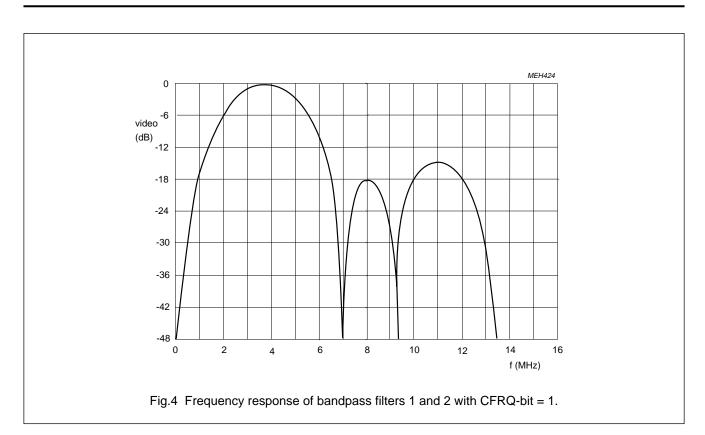
## SAA7152

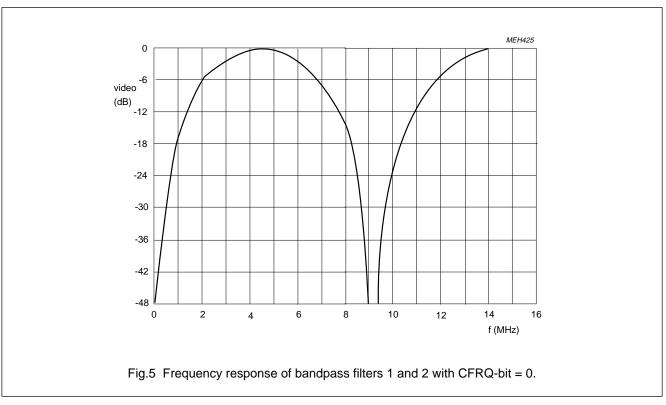
FUNCTION	SUBADDRESS	DATA							
FUNCTION	SUBADDRESS	D7	D6	D5	D4	D3	D2	D1	D0
Controls	00	BYPS	CSEL	CCMB	YCMB	TAPS	CFRQ	NLIN	LLEN

#### Function of the bits of Table 1:

BYPS	Select bypass with a short delay; all other	0 = no bypass			
	functions are disabled:	1 = comb filter bypassed (delay is 3 LLC)			
CSEL	Input mode select:	0 = CVBS selected			
		1 = Y/C selected			
ССМВ	Select comb filtering	0 = chrominance is bandpassed			
		1 = chrominance is comb-filtered			
YCMB	Enable chrominance substruction from	0 = disabled, CVBS/Y signal is only low-passed			
	CVBS signal:	1 = enabled (chrominance trap or comb filtering)			
TAPS	Selects tap for switching Y and C to	0 = for bandpass/low-pass combination			
	adder:	1 = for comb filter active			
CFRQ	Select centre frequency and matching	0 = 4.43 MHz			
	factor of chrominance filter:	1 = 3.58 MHz			
NLIN	Select delay (number of lines):	0 = 4-line comb filter for standard PAL			
		1 = 2-line filter for standard NTSC			
LLEN	Selects the number of clocks for each	0 = 1728 clocks (625 lines; 50 Hz)			
	line delay:	1 = 1716 clocks (525 lines; 60 Hz)			

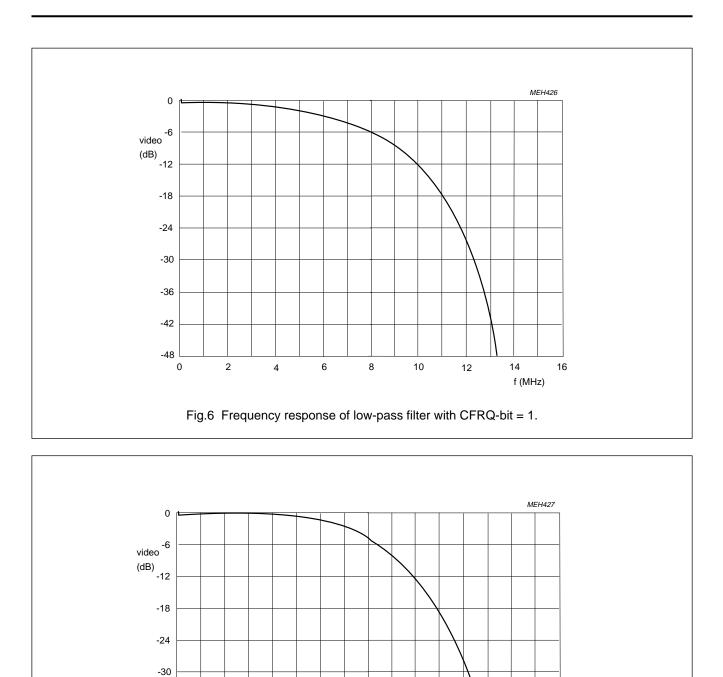
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## Digital Video Comb Filter (DCF)



-36

-42

-48

0

2

8

Fig.7 Frequency response of low-pass filter with CFRQ-bit = 0.

10

12

14

f (MHz)

16

6

4

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#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
V <sub>DD</sub>	supply voltage (pins 11, 34, 44)	-0.5	7.0	V
VI	voltage on all inputs	-0.5	V <sub>DD</sub> + 0.5	V
Vo	voltage on all outputs (I <sub>O max</sub> = 20 mA)		V <sub>DD</sub> + 0.5	V
P <sub>tot</sub>	total power dissipation	-	1.0	W
T <sub>stg</sub>	storage temperature range	-65	150	°C
T <sub>amb</sub>	operating ambient temperature range	0	70	°C
V <sub>ESD</sub>	electrostatic handling <sup>(1)</sup> for all pins	-	±2000	V

#### Note

1. Equivalent to discharging a 100 pF capacitor through a 1.5 kΩ series resistor; inputs and outputs are protected against electrostatic discharge in normal handling. Normal precautions appropriate to handle MOS devices is recommended (see "Handling MOS Devices").

#### **CHARACTERISTICS**

 $V_{DD1}$  to  $V_{DD3}$  = 5 V;  $T_{amb}$  = 0 to 70 °C and measurements taken in Fig.1 unless otherwise specified.

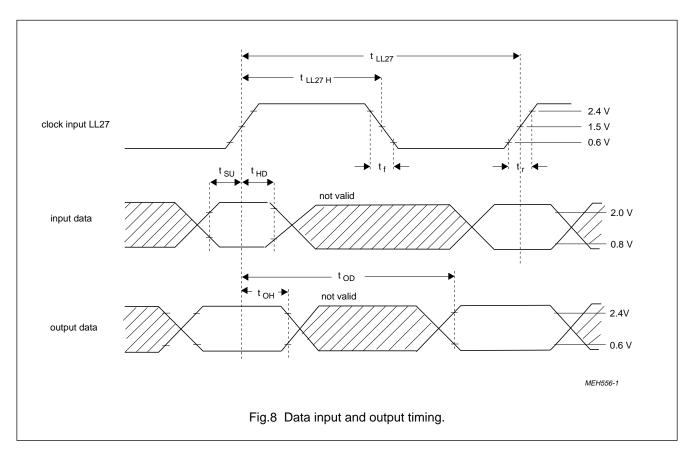
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>DD</sub>	supply voltage range (pins 11, 34, 44)		4.5	5.0	5.5	V
I <sub>DD</sub>	total supply current (pins 11, 34, 44)	V <sub>DD</sub> = 5 V; inputs LOW; outputs not connected	-	85	180	mA
l²C-bus, S	DA and SCL (pins 23 and 24)					
V <sub>IL</sub>	input voltage LOW		-0.5	-	1.5	V
V <sub>IH</sub>	input voltage HIGH		3	_	V <sub>DD</sub> +0.5	V
I <sub>23, 24</sub>	input current		_	_	±10	μA
I <sub>ACK</sub>	output current on pin 23	acknowledge	3	_	-	mA
V <sub>OL</sub>	output voltage at acknowledge	I <sub>23</sub> = 3 mA	-	-	0.4	V
Data and	clock inputs (pins 2 to 10 and pins 13 t	to 20)				
V <sub>IL</sub>	LL27 input voltage (pin 2)	LOW	-0.5	-	0.6	V
V <sub>IH</sub>		HIGH	2.4	-	V <sub>DD</sub> +0.5	V
V <sub>IL</sub>	other input voltages	LOW	-0.5	_	0.8	V
V <sub>IH</sub>		HIGH	2.0	_	V <sub>DD</sub> +0.5	V
l <sub>leak</sub>	input leakage current		_	_	10	μA
CI	input capacitance	data inputs	_	_	8	pF
		clock inputs	-	-	10	pF
t <sub>SU.DAT</sub>	input data set-up time	Fig.8	11	-	-	ns
t <sub>HD.DAT</sub>	input data hold time		3	-	-	ns

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Data outp	uts (pins 25 to 32 and pins 35 to 4	2)	I			-!
V <sub>OL</sub>	output voltage LOW		0	_	0.6	V
V <sub>OH</sub>	output voltage HIGH		2.4	-	V <sub>DD</sub>	V
CL	load capacitor		8	-	25	pF
Timing of	data outputs	Fig.8	•			
t <sub>OH</sub>	output signal hold time from positive edge of LL27	C <sub>L</sub> = 8 pF	3	-	-	ns
t <sub>OD</sub>	output delay from positive edge of LL27	C <sub>L</sub> = 25 pF	-	-	32	ns
Line locke	ed clock input LL27 (pin 2)	Fig.8	•			
t <sub>LL27</sub>	cycle time	note 1	35	_	39	ns
tp	duty factor	t <sub>LL27H</sub> / t <sub>LL27</sub>	40	50	60	%
t <sub>r</sub>	rise time		-	-	5	ns
t <sub>f</sub>	fall time		_	_	6	ns

#### Note

1.  $t_{SU},\,t_{HD},\,t_{OH}$  and  $t_{OD}$  include  $t_r$  and  $t_f.$ 

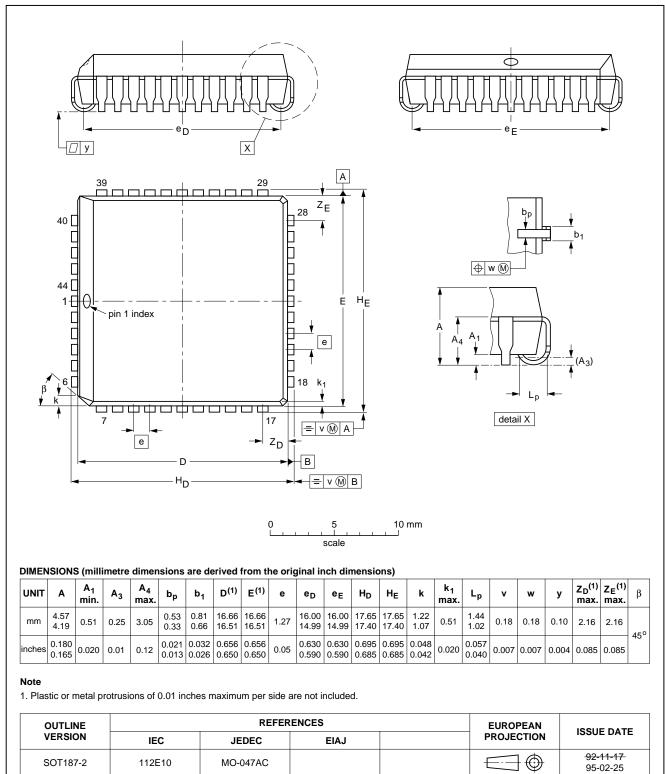


## SAA7152

SOT187-2

#### PACKAGE OUTLINE

#### PLCC44: plastic leaded chip carrier; 44 leads



### SAA7152

#### SOLDERING

#### Introduction

There is no soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and surface mounted components are mixed on one printed-circuit board. However, wave soldering is not always suitable for surface mounted ICs, or for printed-circuits with high population densities. In these situations reflow soldering is often used.

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"IC Package Databook"* (order code 9398 652 90011).

#### **Reflow soldering**

Reflow soldering techniques are suitable for all PLCC and QFP packages.

The choice of heating method may be influenced by larger PLCC or QFP packages (44 leads, or more). If infrared or vapour phase heating is used and the large packages are not absolutely dry (less than 0.1% moisture content by weight), vaporization of the small amount of moisture in them can cause cracking of the plastic body. For more information, refer to the Drypack chapter in our "Quality Reference Handbook" (order code 9397 750 00192).

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several techniques exist for reflowing; for example, thermal conduction by heated belt. Dwell times vary between 50 and 300 seconds depending on heating method. Typical reflow temperatures range from 215 to 250 °C.

Preheating is necessary to dry the paste and evaporate the binding agent. Preheating duration: 45 minutes at 45  $^{\circ}$ C.

#### Wave soldering

#### PLCC

Wave soldering techniques can be used for all PLCC packages if the following conditions are observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The longitudinal axis of the package footprint must be parallel to the solder flow.

• The package footprint must incorporate solder thieves at the downstream corners.

#### QFP

Wave soldering is **not** recommended for QFP packages. This is because of the likelihood of solder bridging due to closely-spaced leads and the possibility of incomplete solder penetration in multi-lead devices.

# If wave soldering cannot be avoided, the following conditions must be observed:

- A double-wave (a turbulent wave with high upward pressure followed by a smooth laminar wave) soldering technique should be used.
- The footprint must be at an angle of 45° to the board direction and must incorporate solder thieves downstream and at the side corners.

#### Even with these conditions, do not consider wave soldering the following packages: QFP52 (SOT379-1), QFP100 (SOT317-1), QFP100 (SOT317-2), QFP100 (SOT382-1) or QFP160 (SOT322-1).

#### METHOD (PLCC AND QFP)

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Maximum permissible solder temperature is 260 °C, and maximum duration of package immersion in solder is 10 seconds, if cooled to less than 150 °C within 6 seconds. Typical dwell time is 4 seconds at 250 °C.

A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

#### **Repairing soldered joints**

Fix the component by first soldering two diagonallyopposite end leads. Use only a low voltage soldering iron (less than 24 V) applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C. When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

### SAA7152

#### DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
more of the limiting values of the device at these or at	accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or may cause permanent damage to the device. These are stress ratings only and operation any other conditions above those given in the Characteristics sections of the specification limiting values for extended periods may affect device reliability.
Application information	

Where application information is given, it is advisory and does not form part of the specification.

#### LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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